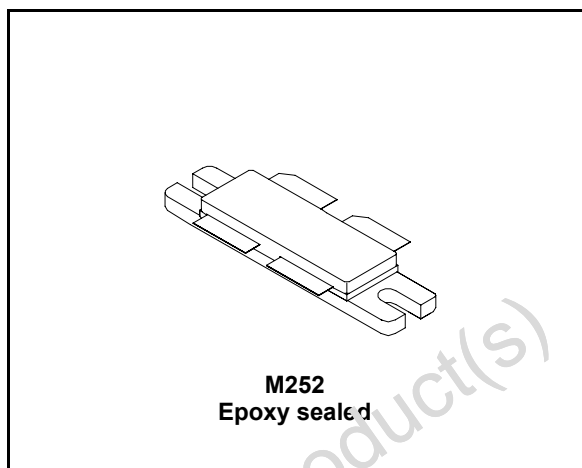


### Features

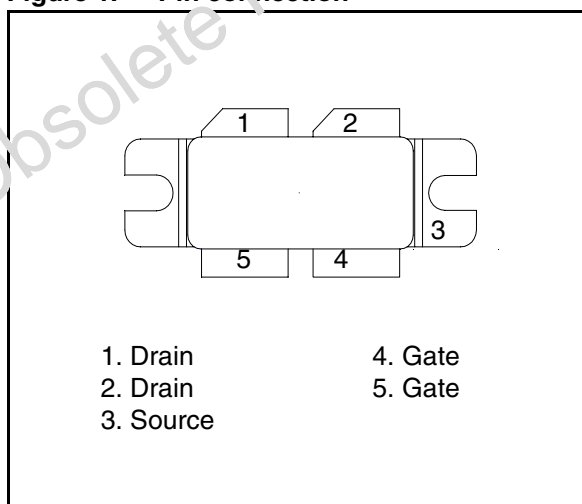
- Excellent thermal stability
- Common source configuration Push-pull
- $P_{OUT} = 150W$  with 13dB gain @ 860MHz / 32V
- BeO free package
- Internal input matching
- In compliance with the 2002/95/EC european directive

### Description

The SD56150 is a common source N-channel enhancement-mode lateral Field-Effect RF power transistor designed for broadband commercial and industrial applications at frequencies up to 1.0 GHz. The SD56150 is designed for high gain and broadband performance operating in common source mode at 32 V. Its internal matching makes it ideal for TV broadcast applications requiring high linearity.



**Figure 1. Pin connection**



**Table 1. Device summary**

Order code	Package	Branding
SD56150	M252	SD56150

# Contents

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# 1 Electrical data

## 1.1 Maximum ratings

**Table 2. Absolute maximum ratings ( $T_{CASE} = 25^{\circ}C$ )**

Symbol	Parameter	Value	Unit
$V_{(BR)DSS}$	Drain-Source Voltage	65	V
$V_{GS}$	Gate-Source Voltage	$\pm 20$	V
$I_D$	Drain Current	17	A
$P_{DISS}$	Power Dissipation (@ $T_c = 70^{\circ}C$ )	236	W
$T_j$	Max. Operating Junction Temperature	200	$^{\circ}C$
$T_{STG}$	Storage Temperature	-65 to +150	$^{\circ}C$

## 1.2 Thermal data

**Table 3. Thermal data**

Symbol	Parameter	Value	Unit
$R_{thJC}$	Junction - case thermal resistance	0.55	$^{\circ}C/W$

## 2 Electrical characteristics

$$T_{\text{CASE}} = +25\text{ }^{\circ}\text{C}$$

### 2.1 Static

**Table 4. Static (per section)**

Symbol	Test conditions		Min	Typ	Max	Unit
$V_{(\text{BR})\text{DSS}}$	$V_{\text{GS}} = 0\text{ V}$	$I_{\text{DS}} = 10\text{ mA}$	65			V
$I_{\text{DSS}}$	$V_{\text{GS}} = 0\text{ V}$	$V_{\text{DS}} = 28\text{ V}$			1	$\mu\text{A}$
$I_{\text{GSS}}$	$V_{\text{GS}} = 20\text{ V}$	$V_{\text{DS}} = 0\text{ V}$			1	$\mu\text{A}$
$V_{\text{GS(Q)}}$	$V_{\text{DS}} = 28\text{ V}$	$I_{\text{D}} = 100\text{ mA}$	2.0		5.0	V
$V_{\text{DS(ON)}}$	$V_{\text{GS}} = 10\text{ V}$	$I_{\text{D}} = 3\text{ A}$		0.5	0.8	V
$G_{\text{FS}}$	$V_{\text{DS}} = 10\text{ V}$	$I_{\text{D}} = 3\text{ A}$	2.5		4	mho
$C_{\text{ISS}}^{(1)}$	$V_{\text{GS}} = 0\text{ V}$	$V_{\text{DS}} = 28\text{ V}$		255		pF
$C_{\text{OSS}}$	$V_{\text{GS}} = 0\text{ V}$	$V_{\text{DS}} = 28\text{ V}$		50		pF
$C_{\text{RSS}}$	$V_{\text{GS}} = 0\text{ V}$	$V_{\text{DS}} = 28\text{ V}$		2.9		pF

1. Includes Internal Input Moscap.

### 2.2 Dynamic

**Table 5. Dynamic**

Symbol	Test conditions		Min	Typ	Max	Unit
$P_{\text{OUT}}$	$V_{\text{DD}} = 32\text{ V}$	$I_{\text{DQ}} = 500\text{ mA}$	150			W
$G_{\text{PS}}$	$V_{\text{DD}} = 32\text{ V}$	$I_{\text{DQ}} = 500\text{ mA}$	13	16.5		dB
$h_{\text{D}}$	$V_{\text{DD}} = 32\text{ V}$	$I_{\text{DQ}} = 500\text{ mA}$	50	60		%
Load mismatch	$V_{\text{DD}} = 32\text{ V}$	$I_{\text{DQ}} = 500\text{ mA}$	10:1			VSWR

### 3 Impedance

Figure 2. Current conventions

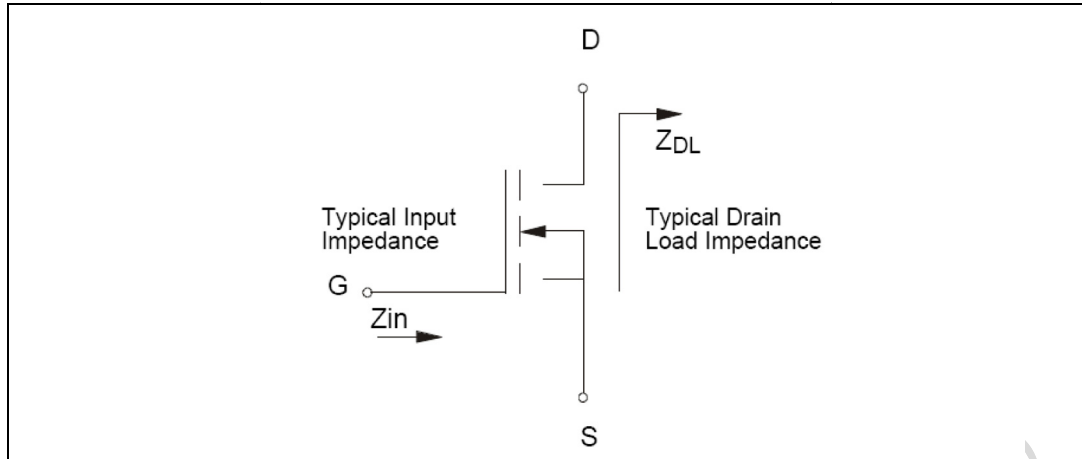


Table 6. Impedance data

Freq. (MHz)	$Z_{IN}$ ( $\Omega$ )	$Z_{DL}$ ( $\Omega$ )
860 MHz	$4.7 - j 5.5$	$3.6 + j 6.5$
880 MHz	$4.3 - j 6.9$	$3.9 + j 7.4$
900 MHz	$4.5 - j 8.8$	$4.4 + j 7.8$

Note: Measured drain to drain and gate to gate respectively.

# 4 Typical performance

Figure 3. Capacitance vs drain voltage

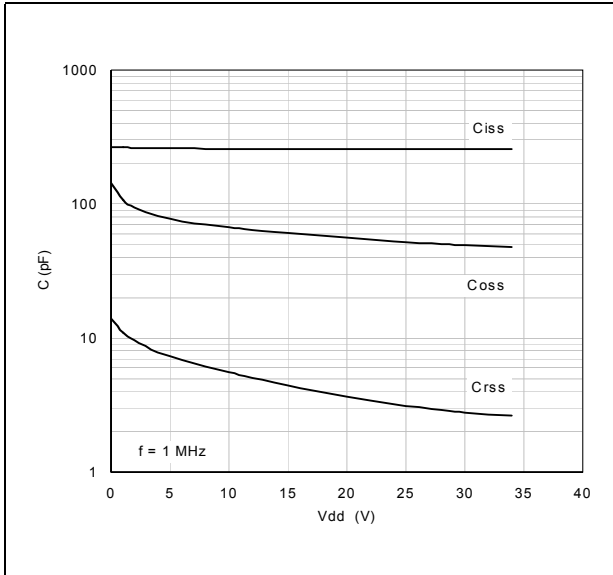


Figure 4. Gate-source voltage vs case temperature

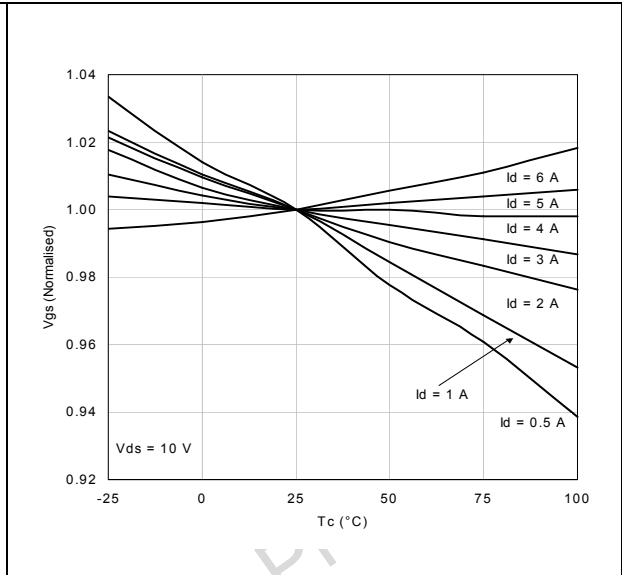


Figure 5. Drain current vs gate voltage

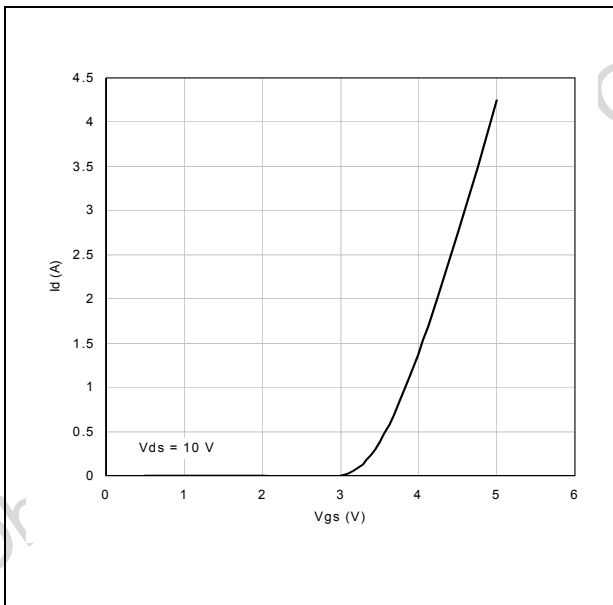


Figure 6. Output power vs input power

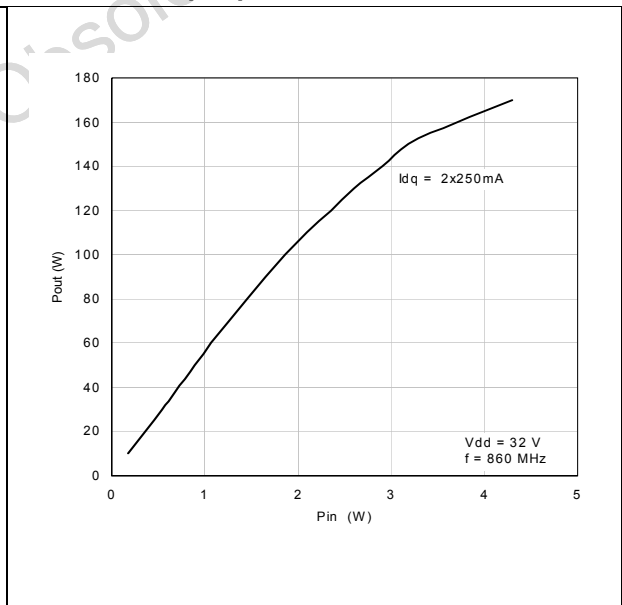


Figure 7. Power gain vs output power

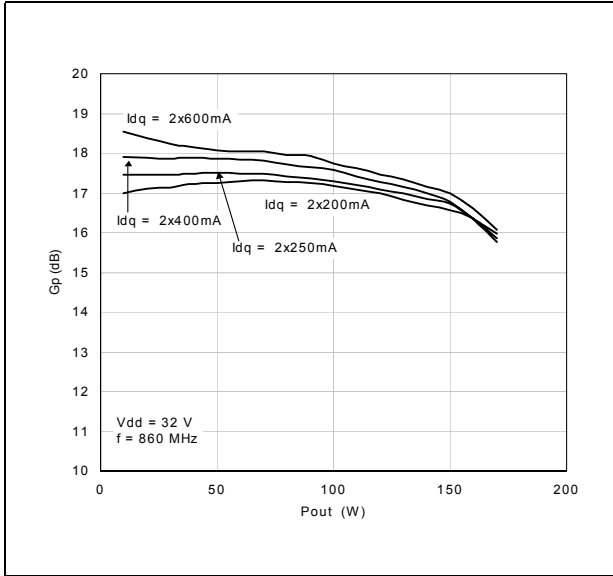


Figure 8. Efficiency vs output power

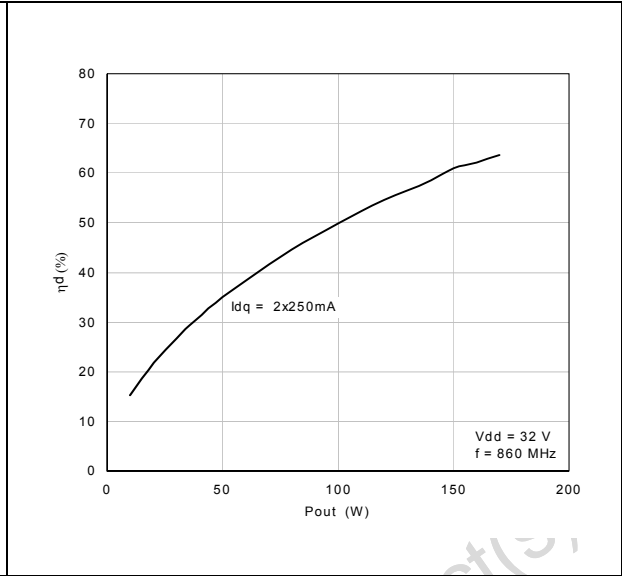


Figure 9. Output power vs supply voltage

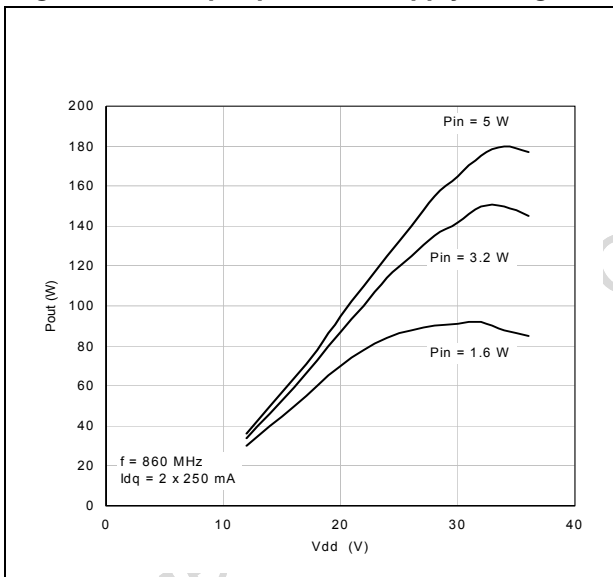


Figure 10. Efficiency vs supply voltage

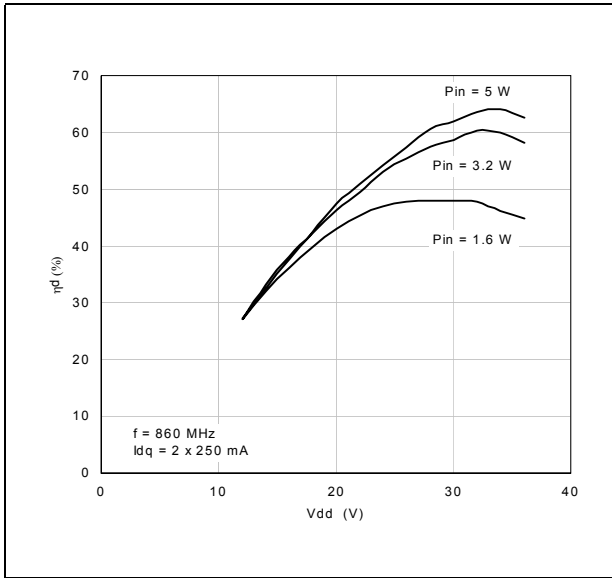
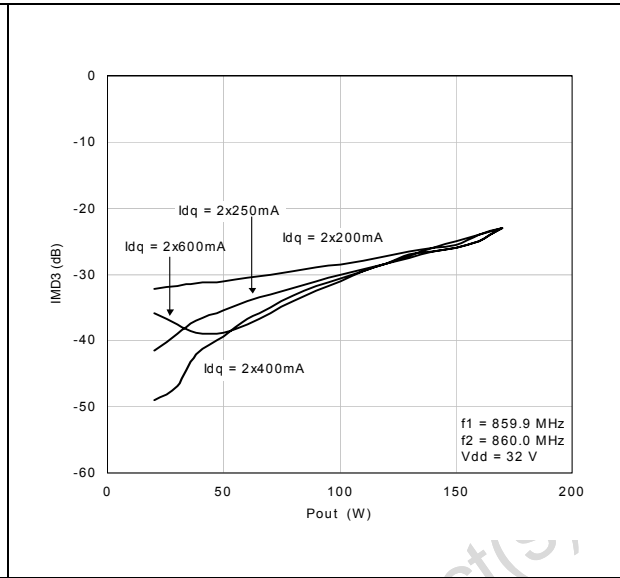


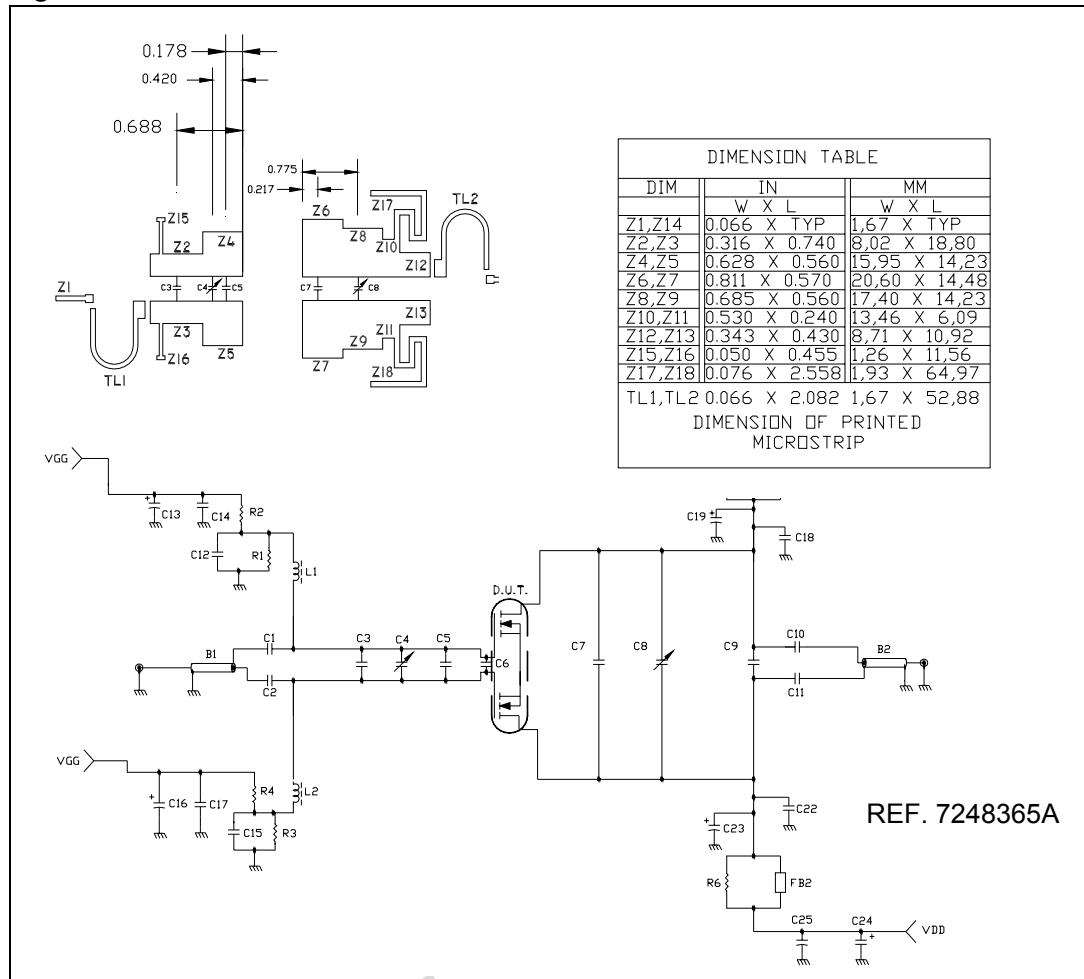
Figure 11. Intermodulation distortion vs output power



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Figure 12. Test circuit schematic



- 1 Gap between ground & transmission line = 0.056 [1.42] +0.002 [0.05] -0.000 [0.00] Typ.
- 2 C3 and C4 adjacent to each other

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Table 7. Test circuit component part list

Component	Description
C1,C2, C10, C11	51 pF ATC 100B SURFACE MOUNT CERAMIC CHIP CAPACITOR
C3	9.1 pF ATC 100B SURFACE MOUNT CERAMIC CHIP CAPACITOR
C4, C8	0.6 - 4.5 pF GIGATRIM VARIABLE CAPACITOR
C5	10 pF ATC 100B SURFACE MOUNT CERAMIC CHIP CAPACITOR
C6	4.7 pF ATC 100A SURFACE MOUNT CERAMIC CHIP CAPACITOR
C7	13 pF ATC 100B SURFACE MOUNT CERAMIC CHIP CAPACITOR
C9	6.2 pF ATC 100B SURFACE MOUNT CERAMIC CHIP CAPACITOR
C12, C15, C18, C22	91 pF ATC 100B SURFACE MOUNT CERAMIC CHIP CAPACITOR
C13, C16, C20, C24	10 $\mu$ F 50V ALUMINUM ELECTROLYTIC RADIAL LEAD CAPACITOR
C14, C17, C21, C25	0.1 $\mu$ F 500V SURFACE MOUNT CERAMIC CHIP CAPACITOR
C19, C23	100 $\mu$ F 63V ALUMINUM ELECTROLYTIC RADIAL LEAD CAPACITOR
R1, R2, R3, R4	200 OHM 1/4 W SURFACE MOUNT CHIP RESISTOR
R5, R6	1.8 OHM 1/4 W SURFACE MOUNT CHIP RESISTOR
L1, L2	CHIP INDUCTOR 10 nH SURFACE MOUNT COIL
FB1, FB2	SURFACE MOUNT EMI SHIELD BEAD
B2, B1	BALUN, 25 OHM, SEMI-RIDGE OD 0.141 2.365 LG COAXIAL CABLE OR EQUIVALENT
PCB	WOVEN GLASS REINFORCED / CERAMIC FILLED 0.030" THK $\epsilon_f = 3.48$ , 2 Oz ED CU BOTH SIDES

Figure 13. Test fixture

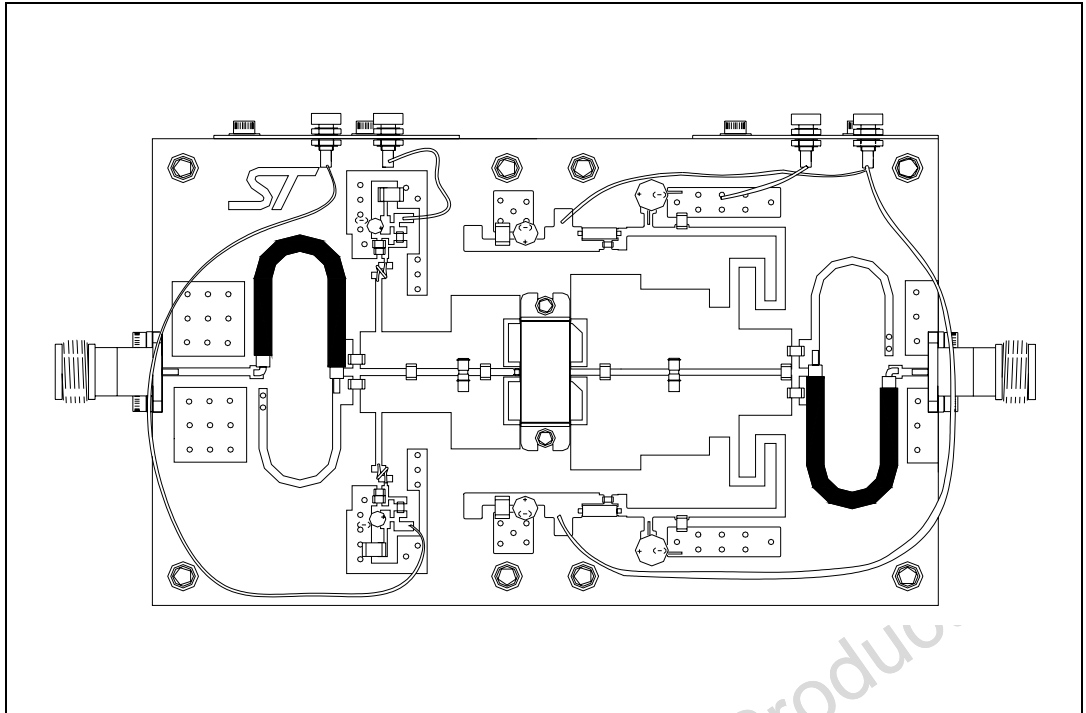
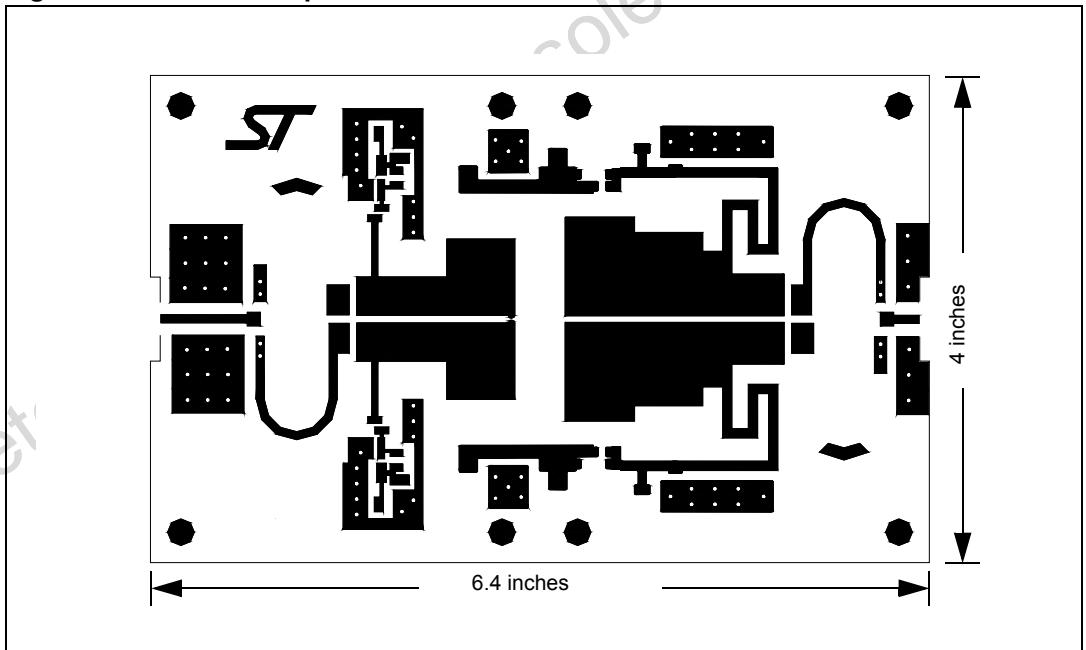


Figure 14. Test circuit photomaster

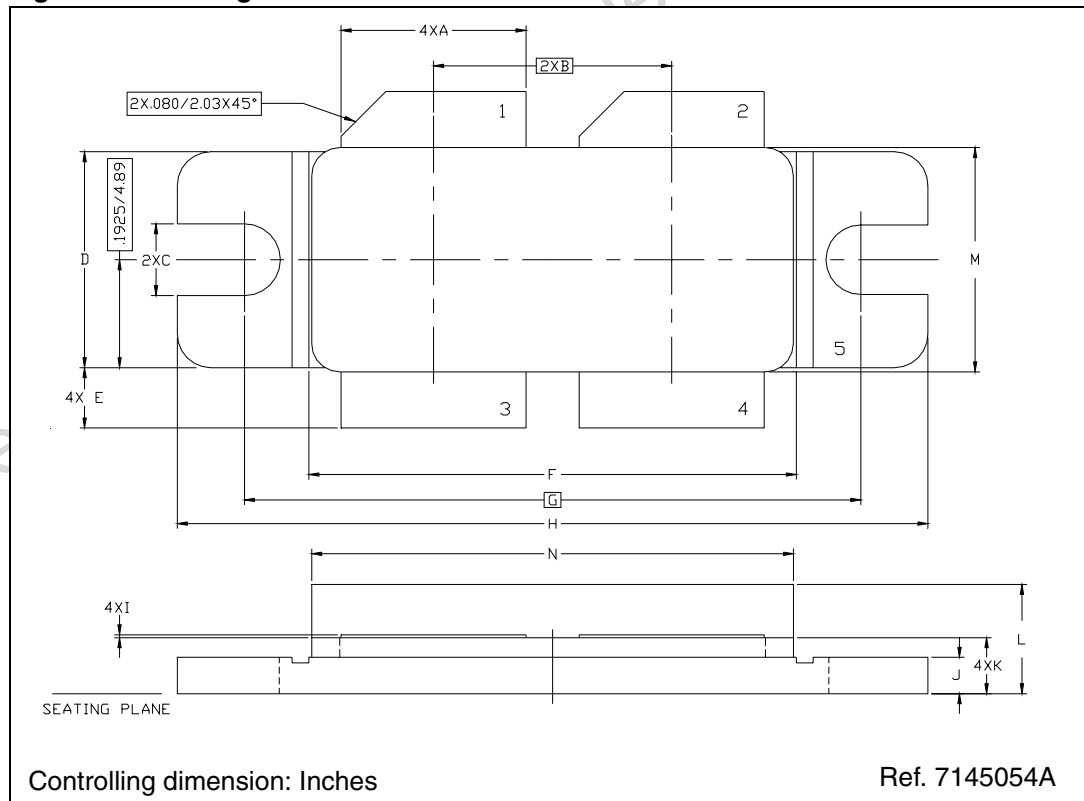


## 5 Package mechanical data

**Table 8. M252 (.400 x .860 4L BAL N/HERM W/FLG) mechanical data**

Dim.	mm.			Inch		
	Min	Typ	Max	Min	Typ	Max
A	8.13		8.64	.320		.340
B		10.80			.425	
C	3.00		3.30	.118		.130
D	9.65		9.91	.380		.390
E	2.16		2.92	.085		.115
F	21.97		22.23	.865		.875
G		27.94			1.100	
H	33.91		34.16	1.335		1.345
I	0.10		0.15	.004		.006
J	1.52		1.78	.060		.070
K	2.36		2.74	.093		.108
L	4.57		5.33	.180		.210
M	9.96		10.34	.392		.407
N	21.64		22.05	.852		.868

**Figure 15. Package dimensions**



## 6 Revision history

**Table 9. Document revision history**

Date	Revision	Changes
12-Sep-2003	5	First Issue
23-Jul-2007	6	Document reformatted, added lead free info
24-Aug-2007	7	Cover page title updated

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